AMMONIA FOR USE IN MANUFACTURE OF GAN-TYPE COMPOUND SEMICONDUCTOR AND METHOD FOR MANUFACTURING GAN-TYPE COMPOUND SEMICONDUCTOR

CROSS REFERENCE TO RELATED APPLICATIONS

This is a Continuation Application of U.S. Proceeding Part No. 6,719,842

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claiming benefit pursuant to 35 U.S.C. §119(e)(i) of

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U.S.C. §111(b).

FIELD OF THE INVENTION

The present invention relates to ammonia for use in the manufacture of a GaN-type compound semiconductor and a method for producing a GaN-type compound semiconductor using the ammonia.

BACKGROUND OF THE INVENTION

Fig. 3 shows an example of conventional GaNtype compound semiconductor devices. The GaN-type compound semiconductor device shown here has a constitution such that a buffer layer 2 comprising $Ga_xAl_{1-x}N$ (wherein $0 \le x \le 1$) which is a GaN-type compound, a Si-doped n-type $Ga_xAl_{1-x}N$ layer (n-type